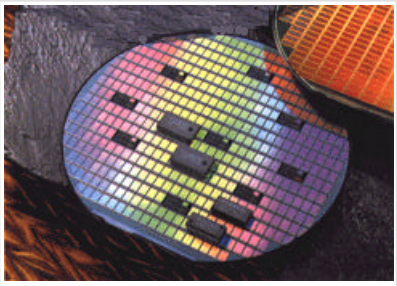
	HYUNDAI
HY62256A-(I) Series	
32Kx8bit CMOS SRAM	
Description	Features
The HY62256A/HY62256A-I is a high-speed, low power and 32,786 x 8-bits CMOS Static Random Access Memory fabricated using Hyundai's high performance CMOS process technology. The HY62256A/HY62256A-I has a data retention mode that guarantees data to remain valid at the minimum power supply voltage of 2.0 volt. Using the CMOS technology, supply voltages from 2.0 to 5.5 volt has little effect on supply current in the data retention mode. The HY62256A/HY62256A-I is suitable for use in low voltage operation and battery back-up application.	■ Fully static operation and Tri-state outputs ■ TTL compatible inputs and outputs ■ Low power consumption -2.0V(min.) data retention ■ Standard pin configuration -28 pin 600 mil PDIP -28 pin 330 mil SOP -28 pin 8x13.4 mm TSOP-1 (standard and reversed)

Product No.	Voltage (V)	Speed (ns)	Operation Current(mA)	Standby Current(uA)			Temperature (°C)
					L	LL	
HY62256A	5.0	55/70/85	50	1mA	100	25	0-70(Normal)
HY62256A-I	5.0	55/70/85	50	1mA	100	-	-40-85(E.T.)

Note
1. E T. Extended Temperature, Normal: Normal Temperature
2. Current value is max.

Features | Pins | Ratings | Timing | Package | Ordering

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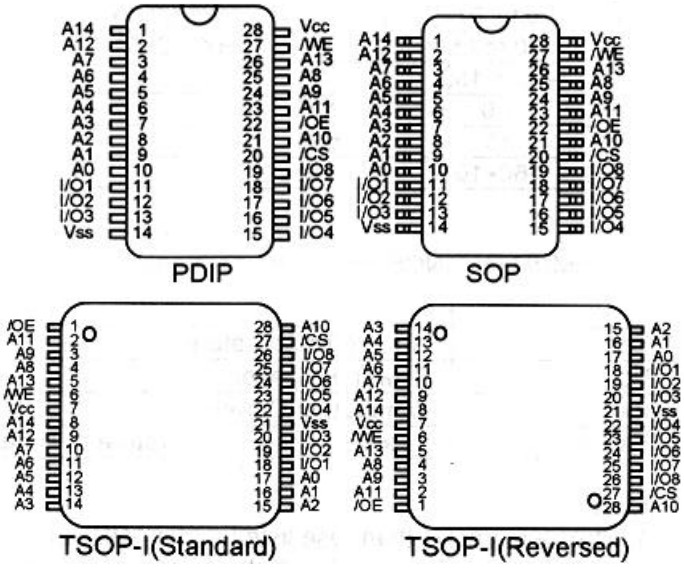
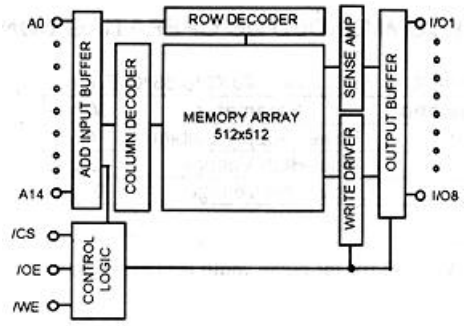
HYUNDAI ELECTRONICS AMERICA **HY62256A-(I) Series** **32Kx8bit CMOS SRAM**	**PIN INFORMATION**

PIN CONNECTION



BLOCK DIAGRAM



PIN DESCRIPTION

Pin Name	Pin Function
/CS	Chip Select
/WE	Write Enable
/OE	Output Enable
A0-A14	Address Inputs
I/O1-I/O8	Data Input/Output
Vcc	Power(+5.0V)
Vss	Ground

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HYUNDAI ELECTRONICS AMERICA **HY62256A-(I) Series** **32Kx8bit CMOS SRAM**	**RATINGS INFORMATION**

ABSOLUTE MAXIMUM RATING (1)

Symbol	Parameter	Rating	Unit	Remark
V_{CC} V_{IN} V_{OUT}	Power Supply Input/Output Voltage	-0.5 to 7.0	V	
T_A	Operating Temperature	0 to 70	°C	HY62256A
		-40 to 85	°C	HY62256A-I
T_{STG}	Storage Temperature	-65 to 150	°C	
P_D	Power Dissipation	1.0	W	
I_{OUT}	Data OutPut Current	50	mA	
T_{SOLDER}	Lead Soldering Temperature & Time	260 /10	°C / sec	

Note

1. Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is stress rating only and the functional operation of the device under these or any other conditions above those indicated in the operation of this specification is not implied. Exposure to the absolute maximum rating conditions for extended period may affect reliability.

RECOMMENDED DC OPERATING CONDITIONS

T_A=0°C to 70°C / T_A= -40°C to 85°C (E.T.)

Symbol	Parameter	Min	Typ	Max	Unit
V_{CC}	Power Supply Voltage	4.5	5.0	5.5	V
V_{IH}	Input High Voltage	2.2	-	V_{CC}+0.5	V
V_{IL}	Input Low Voltage	-0.5(1)	-	0.8	V

Note
1. V_{IL} = -3.0V for pulse width less than 30ns

TRUTH TABLE

/CS	/WE	/OE	MODE	I/O OPERATION
H	X	X	Standby	High-Z
L	H	H	Output Disabled	High-Z
L	H	L	Read	Data Out
L	L	X	Write	Data In

Note:
1. H=V_{IH}, L=V_{IL}, X=Don't Care

Features | Pins | Ratings | Timing | Package | Ordering

DC CHARACTERISTICS

Vcc = 5V ?% T_A = 0°C to 70°C (Normal) / -40°C to 85°C (E.T.) unless otherwise specified

Symbol	Parameter		Test Condition		Min	Typ	Max	Unit
I_{LI}	Input Leakage Current		Vss <= V_{IN} <= Vcc		-1	-	1	uA
I_{LO}	Output Leakage Current		Vss <= V_{OUT} <= Vcc /CS=V_{IH} or /OE=V_{IH} or /WE = V_{IL}		-1	-	1	uA
Icc	Operating Power Supply Current		/CS= V_{IL}, V_{IN}=V_{IH} or V_{IL}, $I_{I/O}$= 0mA		-	30	50	mA
I_{CC1}	Average Operating Current		/CS = V_{IL} Min. Duty Cycle = 100%, $I_{I/O}$ =0mA		-	40	70	mA
I_{SB}	TTL Standby Current (TTL Inputs)		/CS = V_{IH} V_{IN} = V_{IH} or V_{IL}		-	0.4	2	mA
I_{SB1}	CMOS Standby Current (CMOS Input)	HY62256A	/CS >= Vcc-0.2V V_{IN} <= 0.2V or V_{IN} >= V_{CC}-0.2V		-	-	1	mA
				L	-	2	100	uA
				LL	-	1	25	uA
		HY62256A-I			-	-	1	mA
				L	-	2	100	uA
V_{OL}	Output Low Voltage		I_{OL}= 2.1 mA		-	-	0.4	V
V_{OH}	Output High Voltage		I_{OH} = 1mA		2.4	-	-	V

Note: Typical values are at Vcc = 5.0V T_A = 25°C

AC CHARACTERISTICS

Vcc = 5V(±)10%, T_A = 0°C to 70°C (Normal)/ -40°C to 85°C (E.T.) unless otherwise specified.

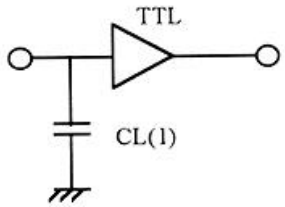
#	Symbol	Parameter	-55		-70		-85		Unit
			Min.	Max.	Min.	Max.	Min.	Max.	
READ CYCLE									
1	tRC	Read Cycle Time	55	-	70	-	85	-	ns
2	tAA	Address Access Time	-	55	-	70	-	85	ns
3	tACS	Chip Select Access Time	-	55	-	70	-	85	ns
4	tOE	Output Enable to Output Valid	-	30	-	35	-	45	ns
5	tCLZ	Chip Select to Output in Low Z	5	-	5	-	5	-	ns
6	tOLZ	Output Enable to Output in Low Z	5	-	5	-	5	-	ns
7	tCHZ	Chip Deselection to Output in High Z	0	20	0	30	0	30	ns
8	tOHZ	Out Disable to Output in High Z	0	20	0	30	0	30	ns
9	tOH	Output Hold from Address Change	5	-	5	-	5	-	ns
WRITE CYCLE									
10	tWC	Write Cycle Time	55	-	70	-	85	-	ns
11	tCW	Chip Selection to End of Write	50	-	65	-	75	-	ns
12	tAW	Address Valid to End of Write	50	-	65	-	75	-	ns
13	tAS	Address Set-up Time	0	-	0	-	0	-	ns
14	tWP	Write Pulse Width	40	-	50	-	55	-	ns
15	tWR	Write Recovery Time	0	-	0	-	0	-	ns
16	tWHZ	Write to Output in High Z	0	20	0	30	0	30	ns
17	tDW	Data to Write Time Overlap	25	-	35	-	40	-	ns
18	tDH	Data Hold from Write Time	0	-	0	-	0	-	ns
19	tOW	Output Active from End of Write	5	-	5	-	5	-	ns

AC TEST CONDITIONS

T_A = 0°C to 70°C (Normal) / -40°C to 85°C (E.T.) unless otherwise specified.

PARAMETER		VALUE
Input Pulse Level		0.8V to 2.4V
Input Rise and Fall Time		5ns
Input and Output Timing Reference Levels		1.5V
Output Load	70/85/100ns	CL = 100pF + 1TTL Load
	55ns	CL = 50pF + 1TTL Load

AC TEST LOADS



Note: Including jig and scope capacitance

CAPACITANCE

T_A= 25 °C, f = 1.0MHz

Symbol	Parameter	Condition	Max	Unit
C_{IN}	Input Capacitance	V_{IN} = 0V	6	pF
$C_{I/O}$	Input/Output Capacitance	$V_{I/O}$= 0V	8	pF

Note: These parameters are sampled and not 100% tested

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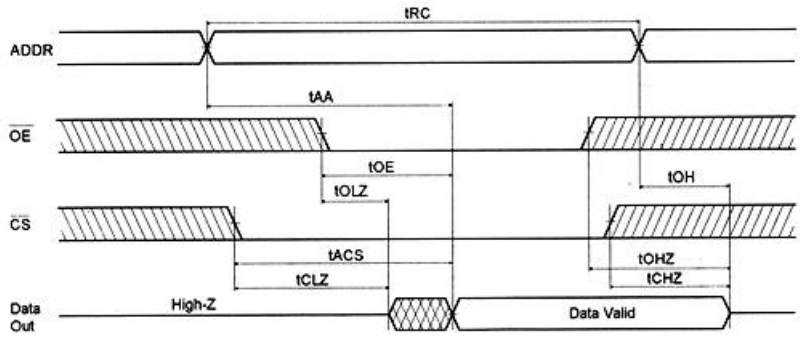
HYUNDAI ELECTRONICS AMERICA HY62256A-I 32K x 8bit CMOS SRAM	TIMING INFORMATION

TIMING DIAGRAM

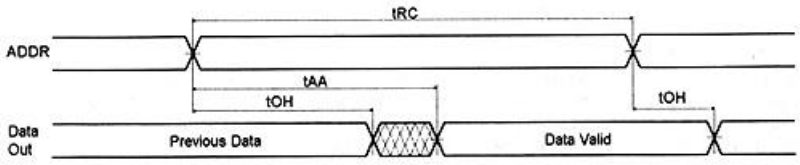
READ CYCLE 1



Note (READ CYCLE):

1. tCHZ and tOHZ are defined as the time at which the outputs achieve the open circuit conditions and are not referenced to output voltage levels.
2. At any given temperature and voltage condition, tCHZ max. is less than tCLZ min. both for a given device and from device to device.
3. /WE is high for the read cycle.

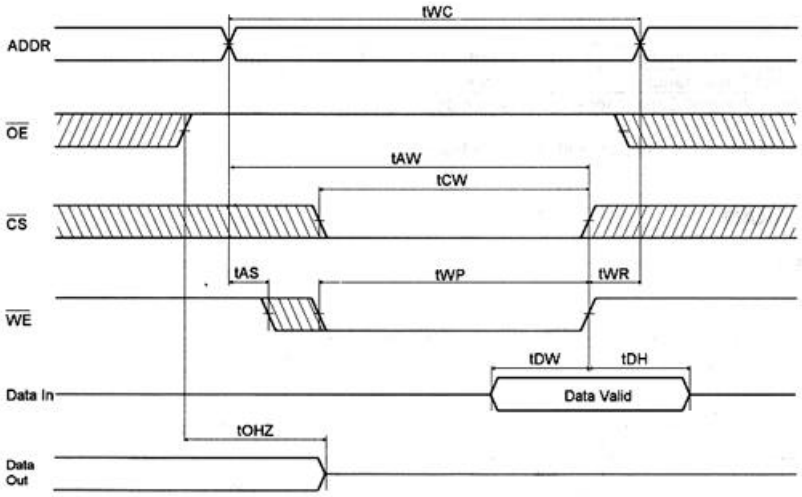
READ CYCLE 2



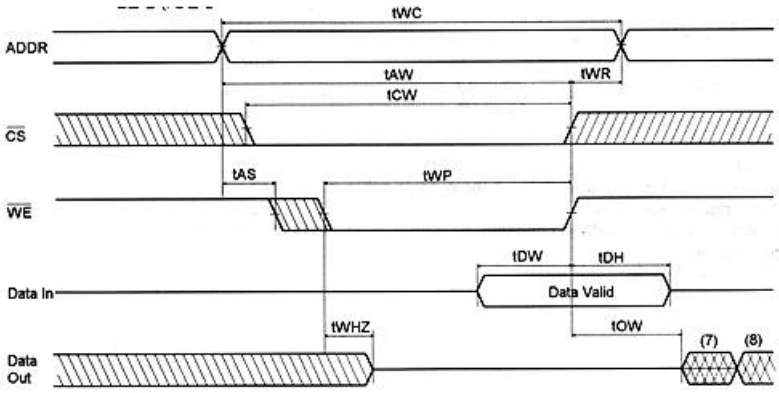
Note (READ CYCLE):

1. /WE is high for the read cycle.
2. Device is continuously selected /CS= VIL.
3. /OE =VIL.

WRITE CYCLE 1 (/OE Clocked)



WRITE CYCLE 2 (/OE Low Fixed)



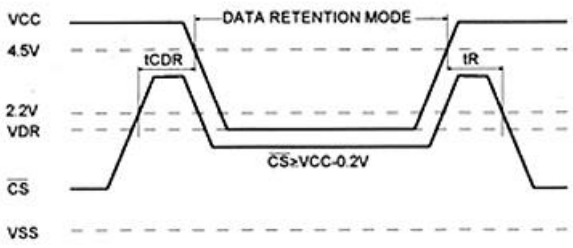
Notes (WRlTE CYCLE):

1. A write occurs during the overlap of a low /CS and a low /WE. A write begins at the latest transition among /CS going low and /WE going low: A write ends at the earliest transition among /CS going high and /WE going high. tWP is measured from the beginning of write to the end of write.
2. tcw is measured from the later of /CS going low to the end of write .
3. tAS is measured from the address valid to the beginning of write.
4. tWR is measured from the end of write to the address change. tWR is applied in case a write ends as /CS, or /WE going high.
5. If /OE and /WE are in the read mode during this period, and the I/O pins are in the output low-Z state, input of opposite phase of the output must not be applied because bus contention can occur.
6. If /CS goes low simultaneously with /WE going low, or after /WE going low, the outputs remain in high impedance state.
7. DOUT is the same phase of latest written data in this write cycle.
8. DOUT is the read data of the new address.

DATA RETENTION CHARACTERISTIC								
T_A= 0°C to 70°C (normal) /-40°C to 85°C (E.T.)								
Symbol	**Parameter**		**Test Condition**		**Min**	**Typ**	**Max**	**Unit**
V_{DR}	Vcc for Data Re! ention		/CS >= Vcc-0.2V Vss <= V_{IN} <= Vcc		2	-	-	V
I_{CCDR}	Data Retention Current	HY62256A	Vcc = 3.0V /CS >= Vcc -0.2V Vss <= V_{IN} <= Vcc	L	-	1	50	uA
				LL	-	1	15(2)	uA
		HY62256A-1		L	-	1	50	uA
tCDR	Chip Disable to Data Retention Time		See Data Retention Timing Diagram		0	-	-	ns
tR	Operating Recovery Time				tRC(3)	-	-	ns

Notes
1. Typical values are under the condition of T_A = 25°C
2. 3uA max. at T_A= 0°C to 40°C
3. tRC is read cycle time.

Data Retention Timing Diagram



RELIABILITY SPEC.		
TEST MODE		**TEST SPEC.**
ESD	HBM	>= 2000V
	MM	>= 250V
LATCH-UP		<= -100mA
		>= 100mA

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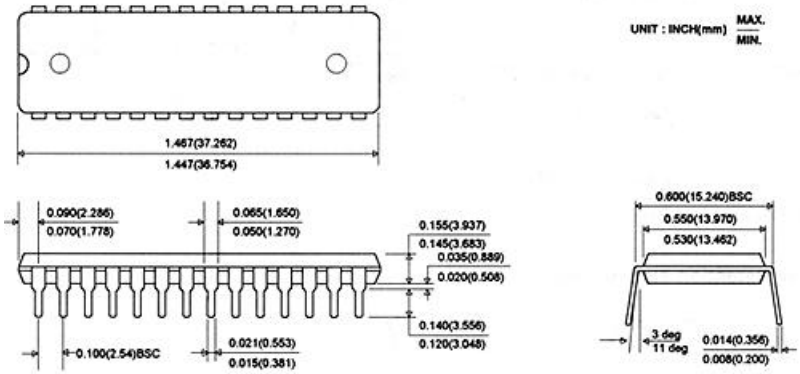
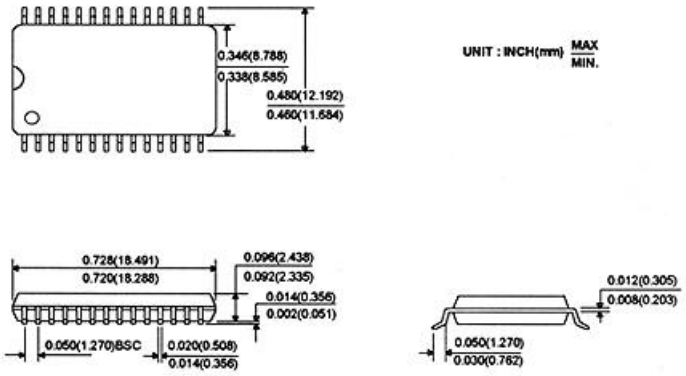
HYUNDAI ELECTRONICS AMERICA HY62256A-(I) Series 32Kx8bit CMOS SRAM	PACKAGE INFORMATION

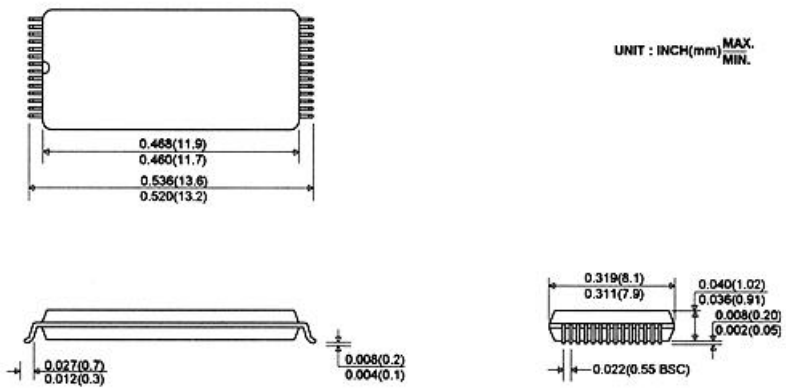
28pin 600mil Dual In-Line Package(P)



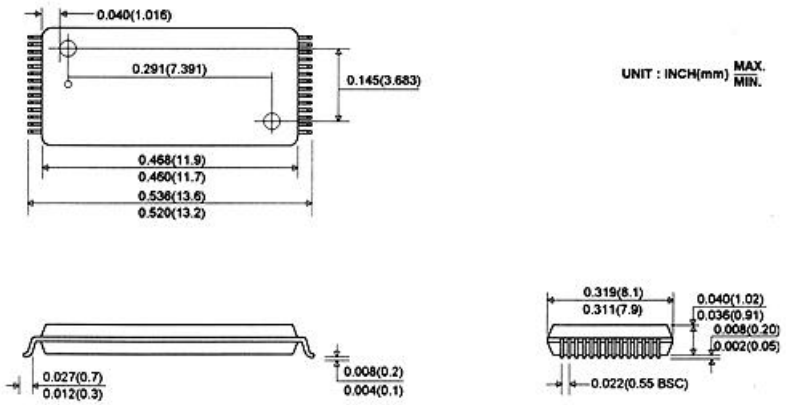
28pin 330mil Small Outline Package(J)



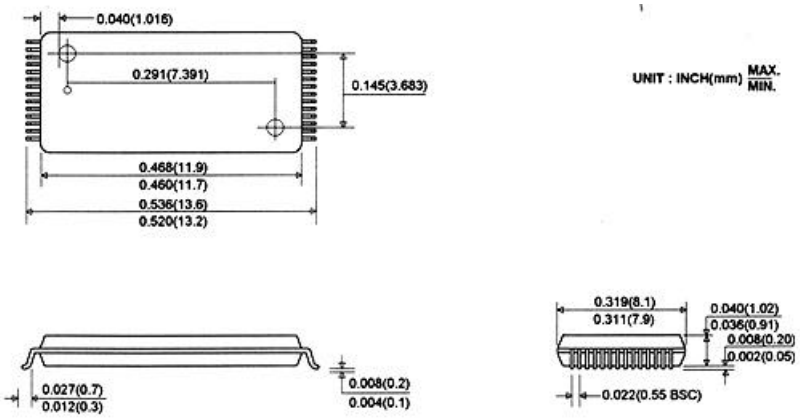
28pin 8X13.4mm Thin Small Outline Package Standard(T1)



28pin 8x13.4mm Thin Small Outline Package Reversed(R1)



28pin 8X13.4mm Thin Small Outline Package SReversed(R1)



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HYUNDAI ELECTRONICS AMERICA **HY62256A-(I) Series** **32Kx8bit CMOS SRAM**	**ORDERING INFORMATION**

Part No.	Speed	Power	Temp.	Package
HY62256AP	55/70/85			PDIP
HY62256ALP	55/70/85	L-part		PDIP
HY62256ALLP	55/70/85	LL-part		PDIP
HY62256AJ	55/70/85			SOP
HY62256ALJ	55/70/85	L-part		SOP
HY62256ALLJ	55/70/85	LL-part		SOP
HY62256AT1	55/70/85			TSOP-I Standard
HY62256ALT1	55/70/85	L-part		TSOP-I Standard
HY62256ALLT1	55/70/85	LL-part		TSOP-I Standard
HY62256AR1	55/70/85			TSOP-I Reversed
HY62256ALR1	55/70/85	L-part		TSOP-I Reversed
HY62256ALLR1	55/70/85	LL-part		TSOP-I Reversed
HY62256AP-I	55/70/85		E.T.	PDIP
HY62256ALP-I	55/70/85	L-part	E.T.	PDIP
HY62256AJ-I	55/70/85		E.T.	SOP
HY62256ALJ-I	55/70/85	L-part	E.T.	SOP
HY62256AT1-I	55/70/85		E .T.	TSOP-I
HY62256ALT1-I	55/70/85	L-part	E.T.	TSOP-I
HY62256AR2-I	55/70/85		E.T.	TSOP-I Reversed
HY62256ALR2-I	55/70/85	L-part	E.T.	TSOP-I Reversed

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